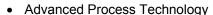


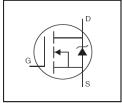
### **AUTOMOTIVE GRADE**

AUIRFS6535 AUIRFSL6535

### HEXFET® Power MOSFET



- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*

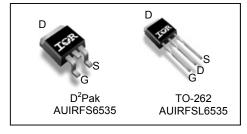


# $\begin{array}{c|c} V_{DSS} & 300V \\ \hline R_{DS(on)} \ typ. & 148 m \Omega \\ \hline max. & 185 m \Omega \\ \hline I_D & 19A \\ \hline \end{array}$

### Description

**Features** 

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Base next number	Dookogo Typo	Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFSL6535	TO-262	Tube	50	AUIRFSL6535
ALUDECESE	D²-Pak	Tube	50	AUIRFS6535
AUIRFS6535 D <sup>2</sup> -Pak		Tape and Reel Left	800	AUIRFS6535TRL

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	19	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	13	Α
I <sub>DM</sub>	Pulsed Drain Current ①	100	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	210	W
	Linear Derating Factor	1.4	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub> Single Pulse Avalanche Energy (Thermally Limited) ②		216	
E <sub>AS</sub> (tested)	AS (tested) Single Pulse Avalanche Energy Tested Value ®		- mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ®		0.71	°C/W
$R_{ heta JA}$	Junction-to-Ambient ( PCB Mount, steady state) ூ		40	C/VV

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	300			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.39		V/°C	Reference to 25°C, I <sub>D</sub> = 5.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		148	185	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 11A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	٧	$V_{DS} = V_{GS}$ , $I_D = 150\mu A$
gfs	Forward Trans conductance	15			S	$V_{DS} = 50V, I_{D} = 11A$
	Drain to Course Leakage Current			20		$V_{DS} = 300V, V_{GS} = 0V$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 300V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	n ^	V <sub>GS</sub> = 20V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

$Q_g$	Total Gate Charge	 38	57		I <sub>D</sub> = 11A
$Q_{gs}$	Gate-to-Source Charge	 12		nC	V <sub>DS</sub> = 150V
$Q_{gd}$	Gate-to-Drain Charge	 13			V <sub>GS</sub> = 10V3
$t_{d(on)}$	Turn-On Delay Time	 15			V <sub>DD</sub> = 300V
t <sub>r</sub>	Rise Time	 16		ns	I <sub>D</sub> = 11A
$t_{d(off)}$	Turn-Off Delay Time	 22		115	$R_G = 5.0\Omega$
t <sub>f</sub>	Fall Time	 10			V <sub>GS</sub> = 10V ③
L <sub>D</sub>	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5			from package and center of die contact
C <sub>iss</sub>	Input Capacitance	 2340			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance	 195			V <sub>DS</sub> = 25V
$C_{rss}$	Reverse Transfer Capacitance	 40		"F	f = 1.0MHz
$C_{oss}$	Output Capacitance	 1750		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
Coss	Output Capacitance	 66			$V_{GS} = 0V$ , $V_{DS} = 240V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 130			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 240V  $

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			19		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			100		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 11A, V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		190	285	ns	$T_J = 25^{\circ}C$ , $I_F = 11A$ , $V_{DD} = 150V$
$Q_{rr}$	Reverse Recovery Charge		990	1485	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )			

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L = 3.6mH,  $R_G = 50\Omega$ ,  $I_{AS} = 11$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- ③ Pulse width  $\leq$  1.0ms; duty cycle  $\leq$  2%.
- $\oplus$  C<sub>oss</sub> eff. is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ® This value determined from sample failure population, starting  $T_J = 25$ °C, L = 3.6mH,  $R_G = 50\Omega$ ,  $I_{AS} = 11A$ ,  $V_{GS} = 10V$ .
- This is applied to D<sup>2</sup>Pak When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ® R<sub>θ</sub> is measured at T<sub>J</sub> approximately 90°C.



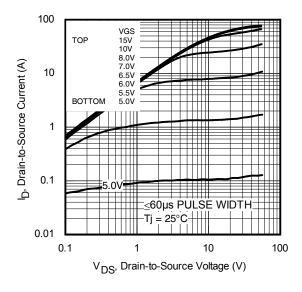


Fig. 1 Typical Output Characteristics

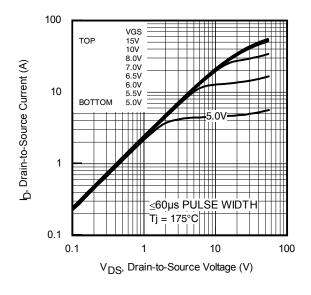


Fig. 2 Typical Output Characteristics

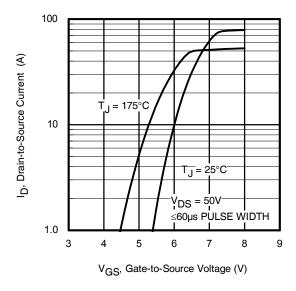


Fig. 3 Typical Transfer Characteristics

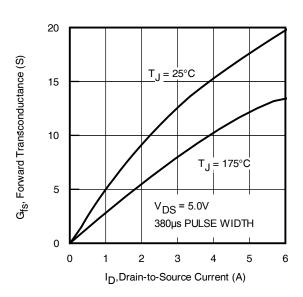
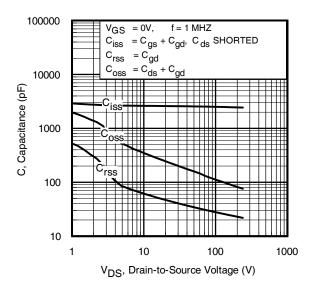
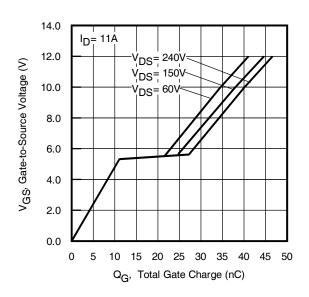


Fig. 4 Typical Forward Trans conductance vs. Drain Current





**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

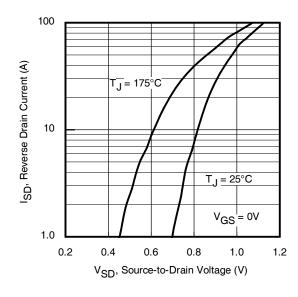


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

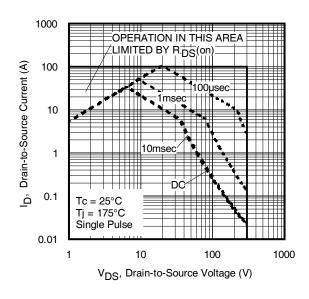
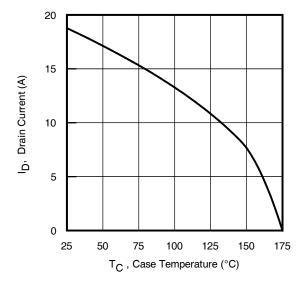


Fig 8. Maximum Safe Operating Area

4





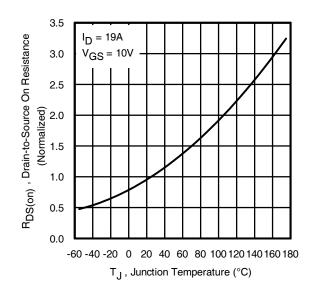


Fig 9. Maximum Drain Current vs. Case Temperature

**Fig 10.** Normalized On-Resistance vs. Temperature

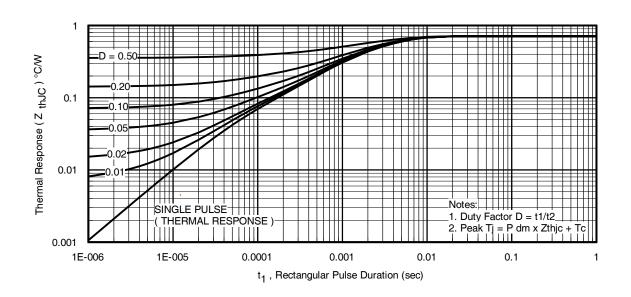


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



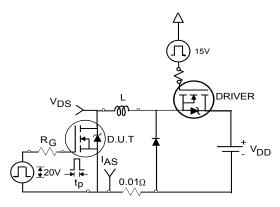


Fig 12a. Unclamped Inductive Test Circuit

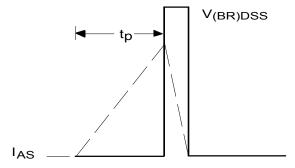


Fig 12b. Unclamped Inductive Waveforms

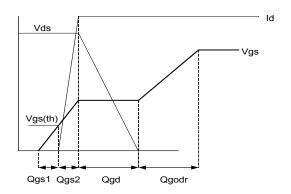


Fig 13a. Gate Charge Waveform

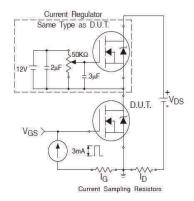
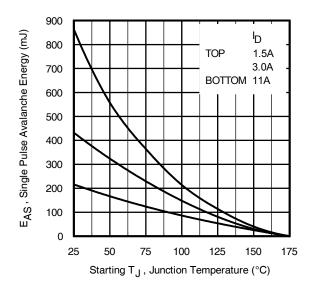


Fig 13b. Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

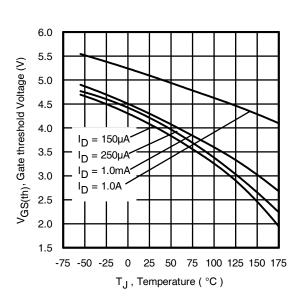


Fig 14. Threshold Voltage vs. Temperature



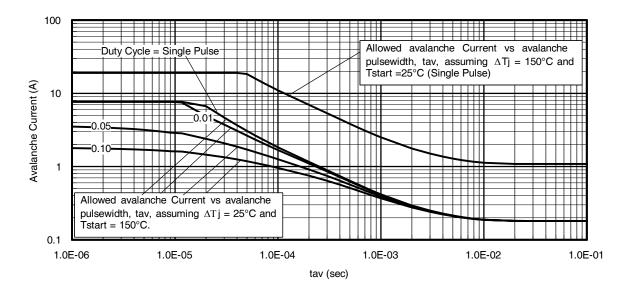
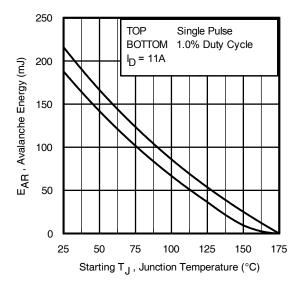


Fig 15. Typical Avalanche Current vs. Pulse width



**Fig 16.** Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



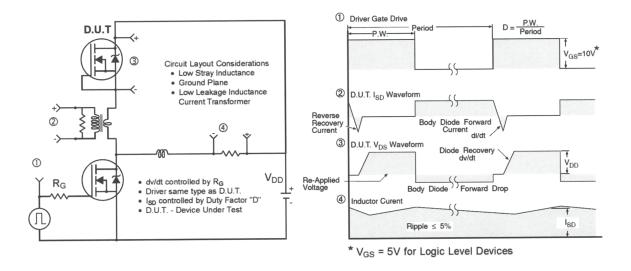


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

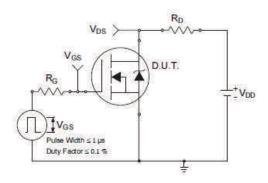


Fig 18a. Switching Time Test Circuit

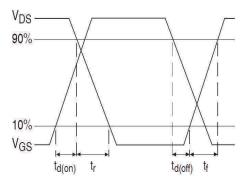
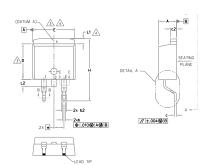
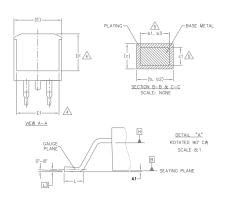


Fig 18b. Switching Time Waveforms



# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S		N			
M B	MILLIMETERS INCHES			O T E S	
0 L	MIN.	MAX.	MIN.	MAX.	S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

### LEAD ASSIGNMENTS

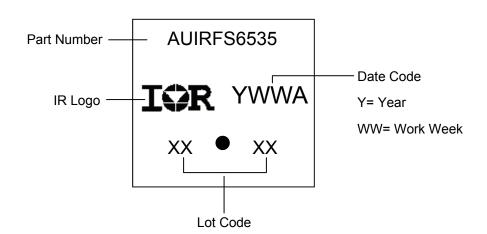
### DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

### HEXFET

IGBTs, CoPACK 1.- GATE 2, 4.- DRAIN 3.- SOURCE 2, 4.- COLLECTOR 3.- EMITTER

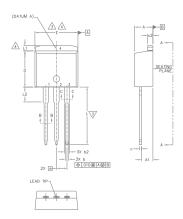
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

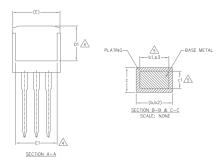


2015-12-4



### TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

### LEAD ASSIGNMENTS

### IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

### HEXFET DIODES

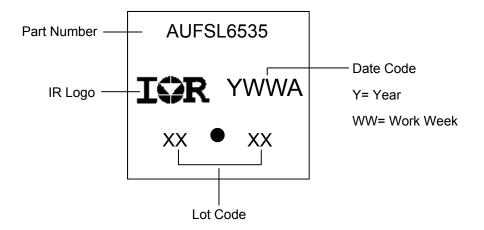
1.- GATE

2.- DRAIN 3.- SOURCE 4.- DRAIN

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

S Y M		N			
В	MILLIMETERS		METERS INCHES		
0 L	MIN.	MAX.	MIN.	MAX.	O T E S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
е	2.54	BSC	.100	BSC	
L	13.46	14.10	.530	.555	
L1	_	1.65	_	.065	4
L2	3.56	3.71	.140	.146	

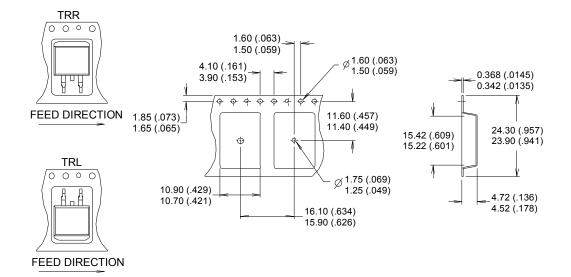
### **TO-262 Part Marking Information**

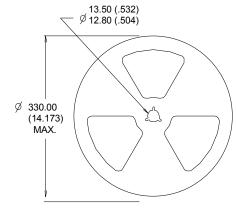


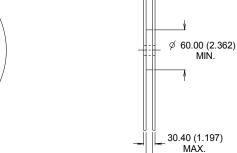
10 2015-12-4



# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







26.40 (1.039)

24.40 (.961)

3

MIŇ.

4

27.40 (1.079) 23.90 (.941) 4

### NOTES:

- COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3
- DIMENSION MEASURED @ HUB.
  INCLUDES FLANGE DISTORTION @ OUTER EDGE.

11 2015-12-4



### **Qualification Information**

		A				
		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		MSL1				
		11021				
Manalaina Manalai		Class M2 (+/-200) <sup>†</sup>				
Macrime Moder	AEC-Q101-002					
House and Deadle Medical	Class H1B (+/-1000V) <sup>†</sup>					
Human Body Model	AEC-Q101-001					
Observed Davids a Madal		Class C5 (+/-2000V) <sup>†</sup>				
Charged Device Model		AEC-Q101-005				
RoHS Compliant		Yes				
	Machine Model Human Body Model Charged Device Model	Industrial and C Automotive leve  TO-262  D²-Pak  Machine Model  Human Body Model  Charged Device Model				

† Highest passing voltage.

### **Revision History**

Date	Comments		
12/4/2015	Updated datasheet with corporate template		
12/4/2013	Corrected ordering table on page 1.		

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**Authorized Distributor** 

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